

Application

- Brushed motor drive applications
- BLDC motor drive applications
- Battery powered circuits
- Half-bridge and full-bridge topologies
- Synchronous rectifier applications
- Resonant mode power supplies
- OR-ing and redundant power switches
- DC/DC and AC/DC converters
- DC/AC inverters

HEXFET® Power MOSFET	
V_{BSS}	40V
$R_{DS(on)}$ typ. max	2.6mΩ 3.3mΩ
I_D	80A



G	D	S
Gate	Drain	Source

Base part number	Package Type	Standard Pack		Orderable Part Number
		Form	Quantity	
IRFI7446GPbF	TO-220 Full-Pak	Tube	50	IRFI7446GPbF

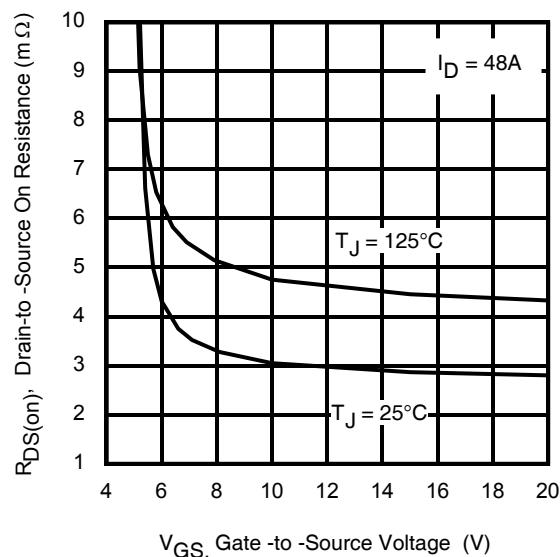


Fig 1. Typical On-Resistance vs. Gate Voltage

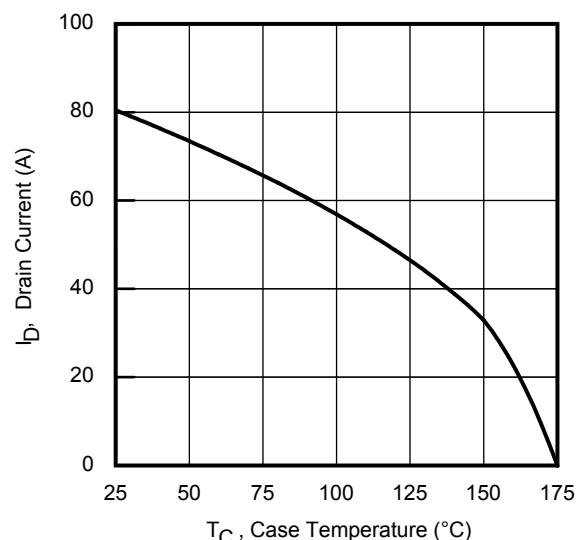


Fig 2. Maximum Drain Current vs. Case Temperature

Absolute Maximum Rating

Symbol	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	80	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	57	
I_{DM}	Pulsed Drain Current ①	320	
$P_D @ T_C = 25^\circ C$	Maximum Power Dissipation	40.5	W
	Linear Derating Factor	0.27	W/ $^\circ C$
V_{GS}	Gate-to-Source Voltage	± 20	V
T_J	Operating Junction and		$^\circ C$
T_{STG}	Storage Temperature Range	-55 to + 175	
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting Torque, 6-32 or M3 Screw	10 lbf·in (1.1 N·m)	

Avalanche Characteristics

EAS (Thermally limited)	Single Pulse Avalanche Energy ②	233	mJ
EAS (tested)	Single Pulse Avalanche Energy Tested Value ⑧	319	
I_{AR}	Avalanche Current ①	See Fig. 15, 16, 23a, 23b	A
E_{AR}	Repetitive Avalanche Energy ①		mJ

Thermal Resistance

Symbol	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ⑦	—	3.7	$^\circ C/W$
$R_{\theta JA}$	Junction-to-Ambient		65	

Static @ $T_J = 25^\circ C$ (unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	40	—	—	V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	38	—	mV/ $^\circ C$	Reference to $25^\circ C, I_D = 1.0mA$ ①
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	2.6	3.3	$m\Omega$	$V_{GS} = 10V, I_D = 48A$
$V_{GS(th)}$	Gate Threshold Voltage	2.2	3.0	3.9	V	$V_{DS} = V_{GS}, I_D = 100\mu A$
I_{DSS}	Drain-to-Source Leakage Current	—	—	1.0	μA	$V_{DS} = 40V, V_{GS} = 0V$
		—	—	150		$V_{DS} = 40V, V_{GS} = 0V, T_J = 125^\circ C$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{GS} = -20V$
R_G	Gate Resistance	—	1.3	—	Ω	

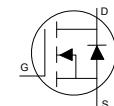
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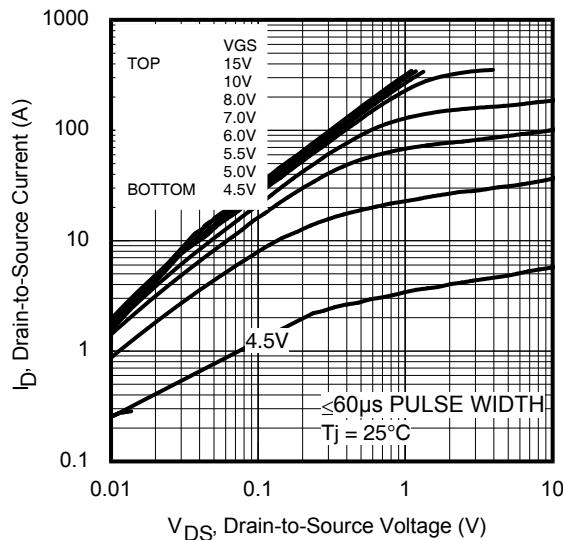
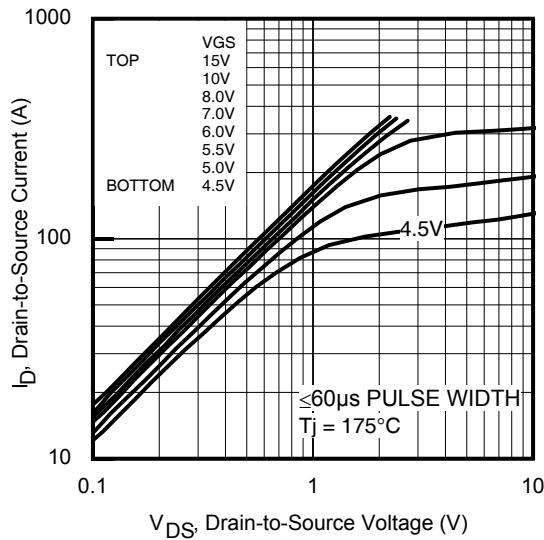
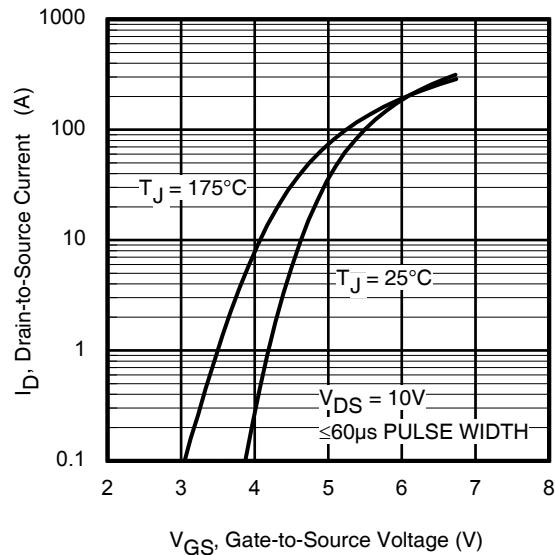
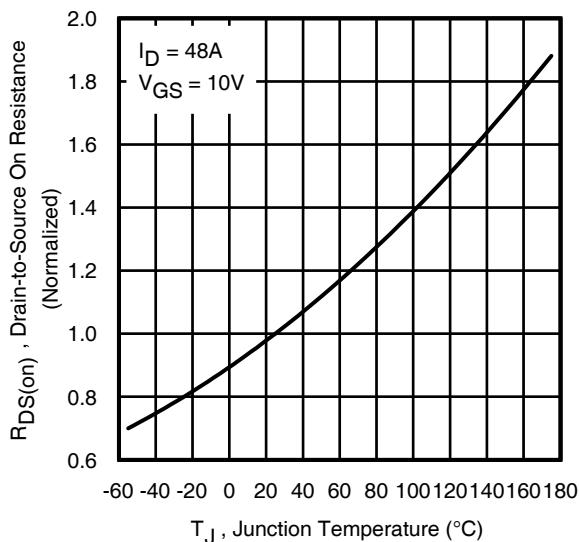
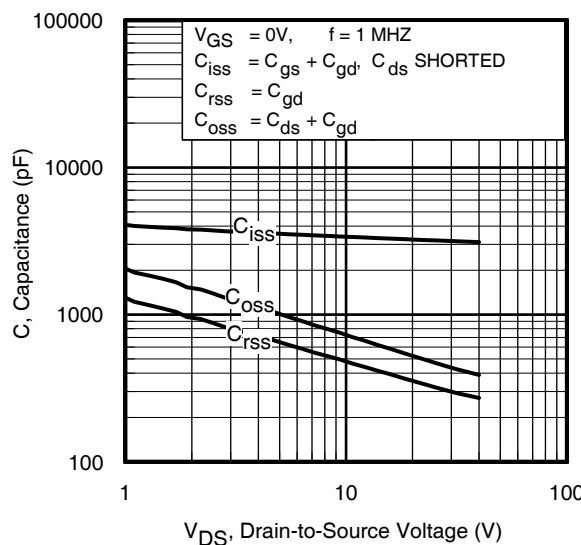
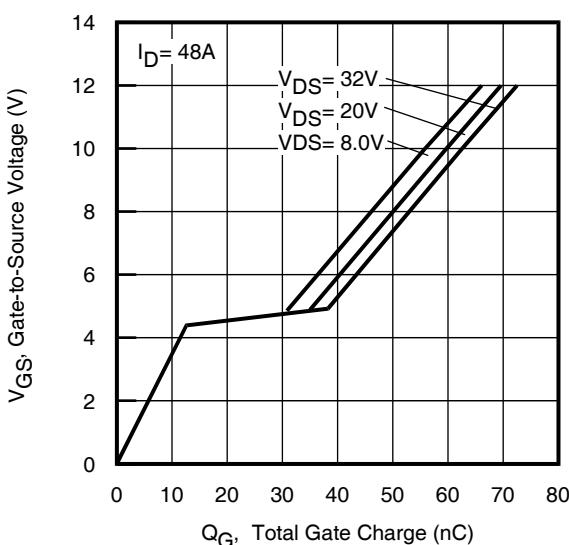
- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Limited by T_{Jmax} , starting $T_J = 25^\circ C$, $L = 270\mu H$, $R_G = 50\Omega$, $I_{AS} = 48A$, $V_{GS} = 10V$.
- ③ $I_{SD} \leq 48A$, $dI/dt \leq 894A/\mu s$, $V_{DD} \leq V_{(BR)DSS}$, $T_J \leq 175^\circ C$.
- ④ Pulse width $\leq 400\mu s$; duty cycle $\leq 2\%$.
- ⑤ C_{oss} eff. (TR) is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .
- ⑥ C_{oss} eff. (ER) is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .
- ⑦ R_θ is measured at T_J approximately $90^\circ C$.
- ⑧ This value determined from sample failure population, starting $T_J = 25^\circ C$, $L = 270\mu H$, $R_G = 50\Omega$, $I_{AS} = 48A$, $V_{GS} = 10V$.

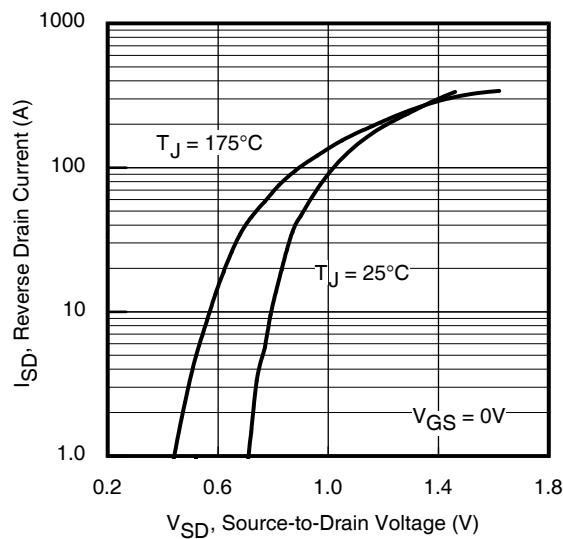
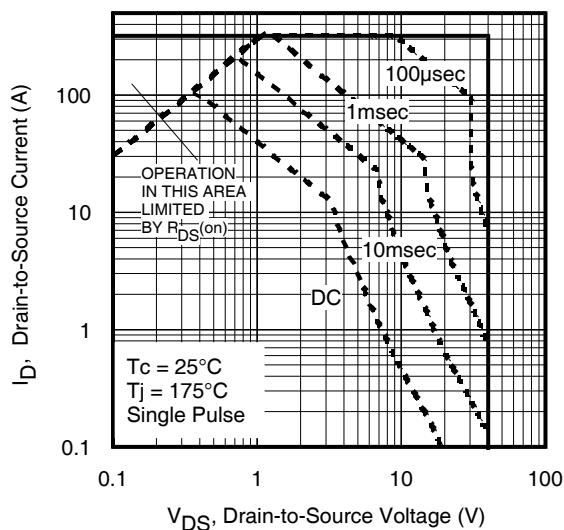
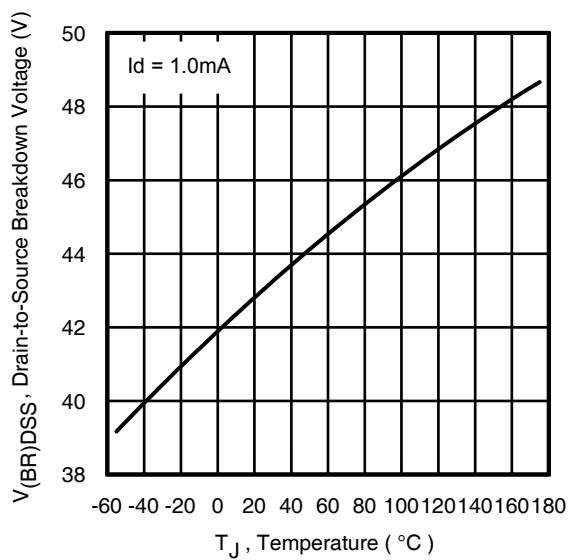
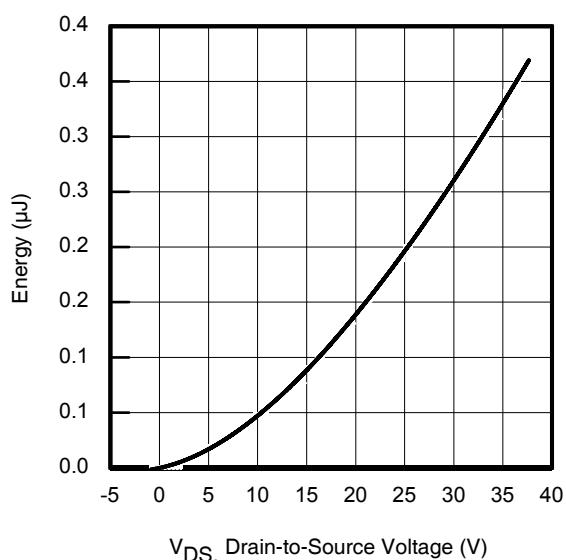
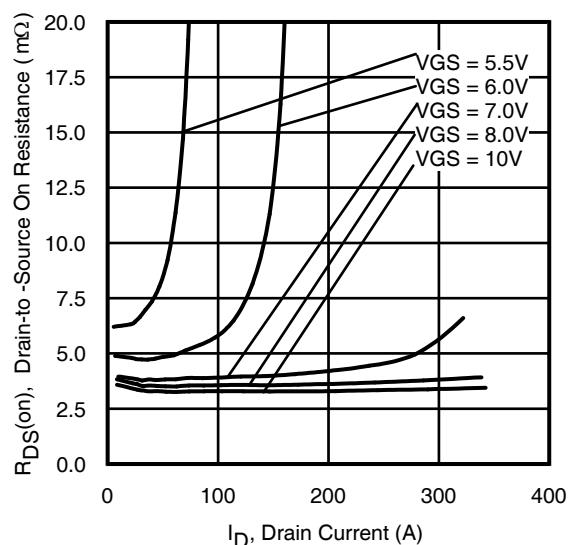
Dynamic Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
g_{fs}	Forward Transconductance	139	—	—	S	$V_{DS} = 10\text{V}$, $I_D = 48\text{A}$
Q_g	Total Gate Charge	—	60	90	nC	$I_D = 48\text{A}$
Q_{gs}	Gate-to-Source Charge	—	13	—		$V_{DS} = 20\text{V}$
Q_{gd}	Gate-to-Drain Charge	—	22	—		$V_{GS} = 10\text{V}$
Q_{sync}	Total Gate Charge Sync. ($Q_g - Q_{gd}$)	—	38	—		
$t_{d(on)}$	Turn-On Delay Time	—	13	—	ns	$V_{DD} = 20\text{V}$
t_r	Rise Time	—	68	—		$I_D = 48\text{A}$
$t_{d(off)}$	Turn-Off Delay Time	—	29	—		$R_G = 2.7\Omega$
t_f	Fall Time	—	26	—		$V_{GS} = 10\text{V}$ ④
C_{iss}	Input Capacitance	—	3199	—	pF	$V_{GS} = 0\text{V}$
C_{oss}	Output Capacitance	—	473	—		$V_{DS} = 25\text{V}$
C_{rss}	Reverse Transfer Capacitance	—	320	—		$f = 1.0\text{MHz}$, See Fig.7
$C_{oss\ eff.(ER)}$	Effective Output Capacitance (Energy Related)	—	561	—		$V_{GS} = 0\text{V}$, $V_{DS} = 0\text{V}$ to 32V ⑥
$C_{oss\ eff.(TR)}$	Output Capacitance (Time Related)	—	679	—		$V_{GS} = 0\text{V}$, $V_{DS} = 0\text{V}$ to 32V ⑤

Diode Characteristics

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
I_s	Continuous Source Current (Body Diode)①	—	—	80	A	MOSFET symbol showing the integral reverse p-n junction diode.
I_{SM}	Pulsed Source Current (Body Diode) ①	—	—	320		
V_{SD}	Diode Forward Voltage	—	—	1.3	V	$T_J = 25^\circ\text{C}$, $I_s = 48\text{A}$, $V_{GS} = 0\text{V}$ ④
dv/dt	Peak Diode Recovery dv/dt ③	—	6.6	—	V/ns	$T_J = 175^\circ\text{C}$, $I_s = 48\text{A}$, $V_{DS} = 40\text{V}$ ③
t_{rr}	Reverse Recovery Time	—	28	—	ns	$T_J = 25^\circ\text{C}$ $V_{DD} = 34\text{V}$
		—	29	—		$T_J = 125^\circ\text{C}$ $I_F = 48\text{A}$,
Q_{rr}	Reverse Recovery Charge	—	25	—	nC	$T_J = 25^\circ\text{C}$ $di/dt = 100\text{A}/\mu\text{s}$ ④
		—	27	—		$T_J = 125^\circ\text{C}$
I_{RRM}	Reverse Recovery Current	—	1.5	—	A	$T_J = 25^\circ\text{C}$

**Fig 3.** Typical Output Characteristics**Fig 4.** Typical Output Characteristics**Fig 5.** Typical Transfer Characteristics**Fig 6.** Normalized On-Resistance vs. Temperature**Fig 7.** Typical Capacitance vs. Drain-to-Source Voltage**Fig 8.** Typical Gate Charge vs. Gate-to-Source Voltage

**Fig 9.** Typical Source-Drain Diode Forward Voltage**Fig 10.** Maximum Safe Operating Area**Fig 11.** Drain-to-Source Breakdown Voltage**Fig 12.** Typical C_{oss} Stored Energy**Fig 13.** Typical On-Resistance vs. Drain Current

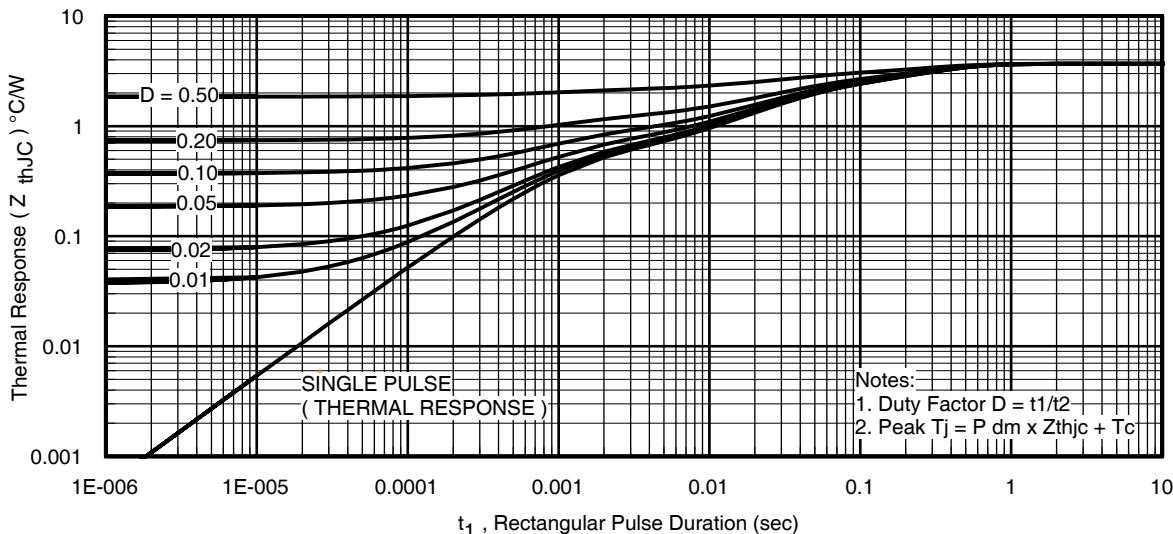


Fig 14. Maximum Effective Transient Thermal Impedance, Junction-to-Case

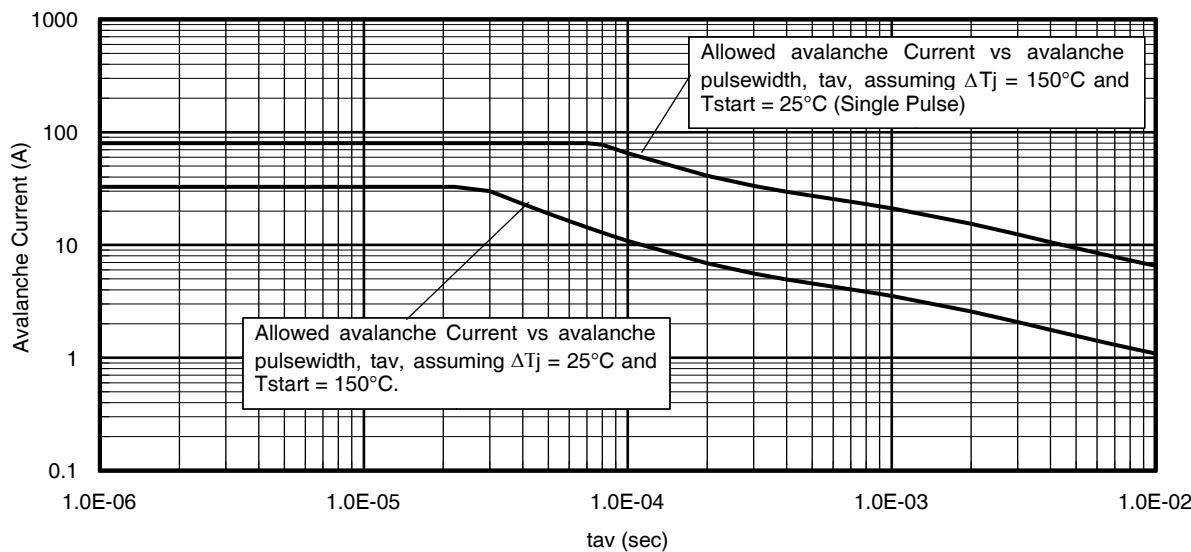


Fig 15. Avalanche Current vs. Pulse Width

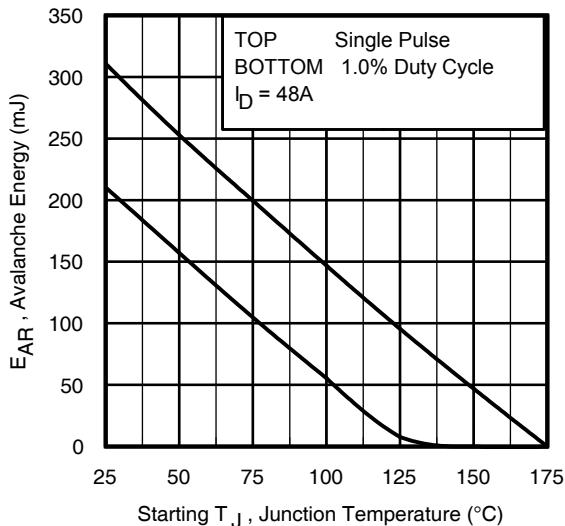
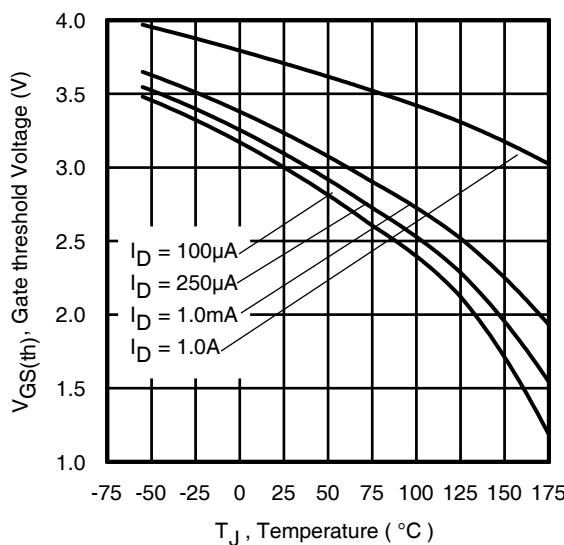
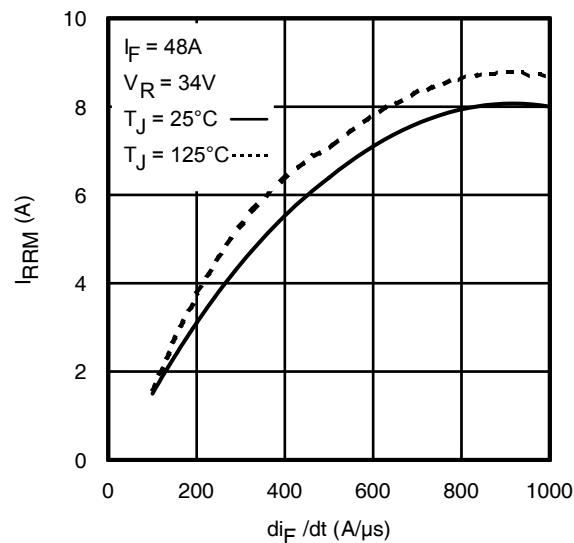
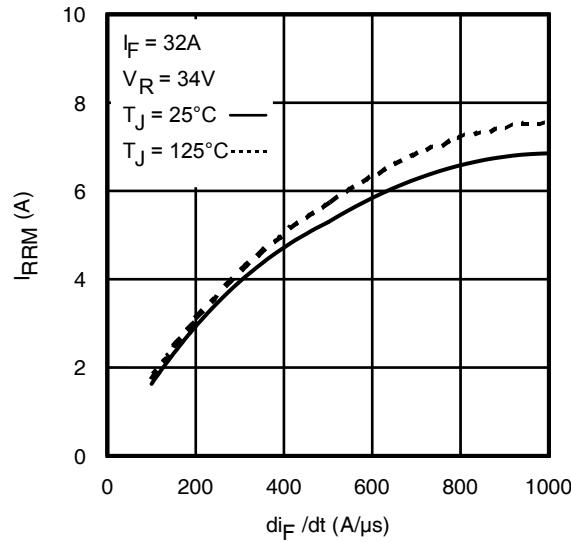
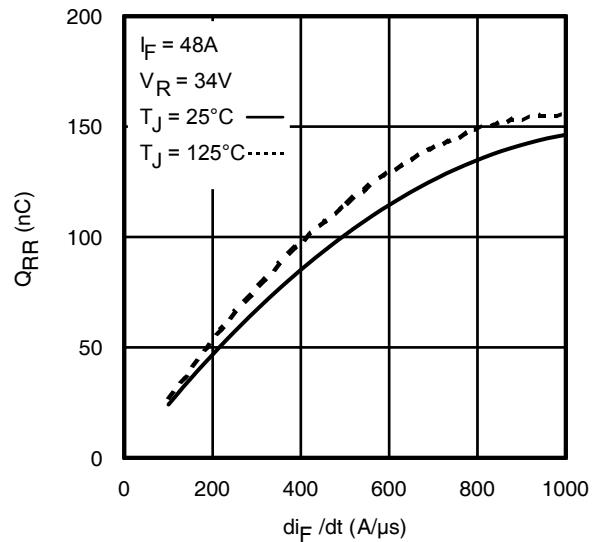
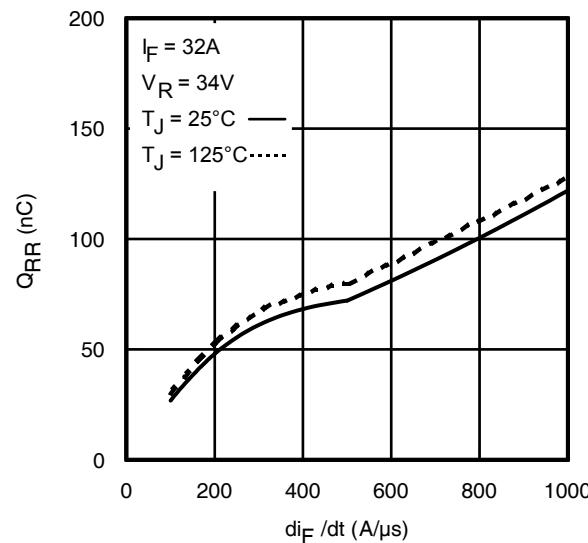


Fig 16. Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves , Figures 15, 16: (For further info, see AN-1005 at www.irf.com)

1. Avalanche failures assumption:
Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax} . This is validated for every part type.
 2. Safe operation in Avalanche is allowed as long as T_{jmax} is not exceeded.
 3. Equation below based on circuit and waveforms shown in Figures 23a, 23b.
 4. $P_{D(ave)}$ = Average power dissipation per single avalanche pulse.
 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
 6. I_{av} = Allowable avalanche current.
 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as $25^{\circ}C$ in Figure 14, 15).
- t_{av} = Average time in avalanche.
 D = Duty cycle in avalanche = t_{av}/f
 $Z_{thJC}(D, t_{av})$ = Transient thermal resistance, see Figures 13)
 $P_D(ave) = 1/2 (1.3 \cdot BV \cdot I_{av}) = \Delta T / Z_{thJC}$
 $I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$
 $EAS(AR) = P_D(ave) \cdot t_{av}$

**Fig 17.** Threshold Voltage vs. Temperature**Fig 18.** Typical Recovery Current vs. di/dt **Fig 19.** Typical Recovery Current vs. di/dt **Fig 20.** Typical Stored Charge vs. di/dt **Fig 21.** Typical Stored Charge vs. di/dt

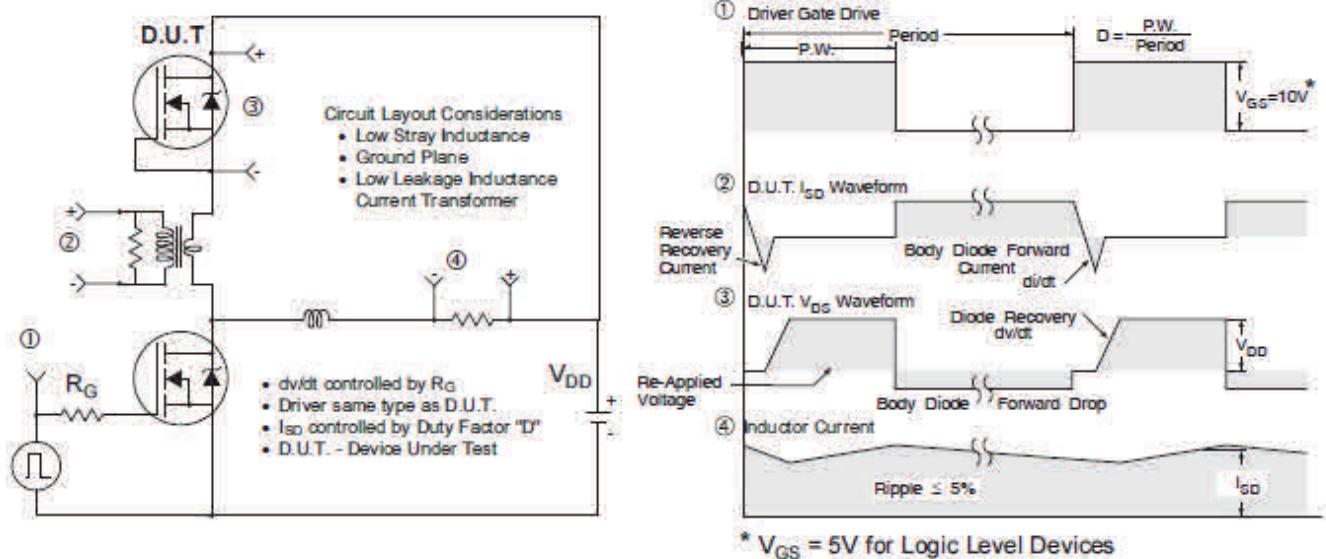


Fig 22. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

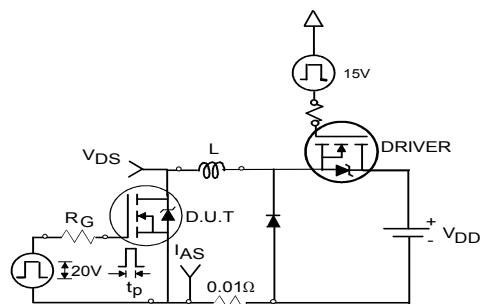


Fig 23a. Unclamped Inductive Test Circuit

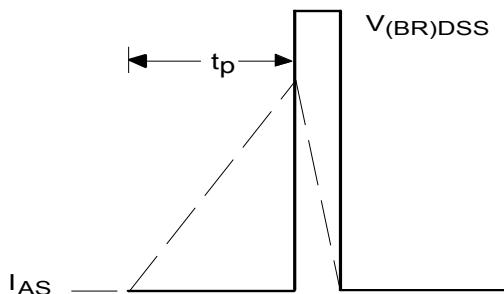


Fig 23b. Unclamped Inductive Waveforms

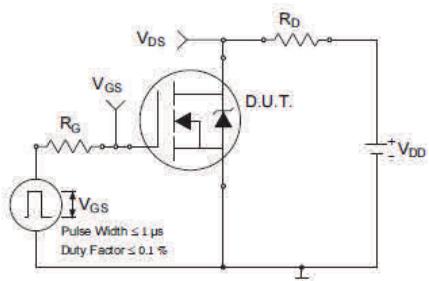


Fig 24a. Switching Time Test Circuit

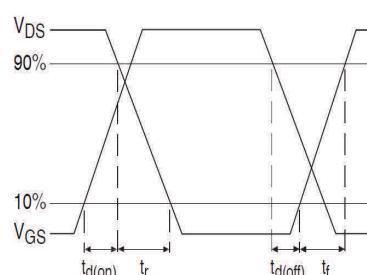


Fig 24b. Switching Time Waveforms

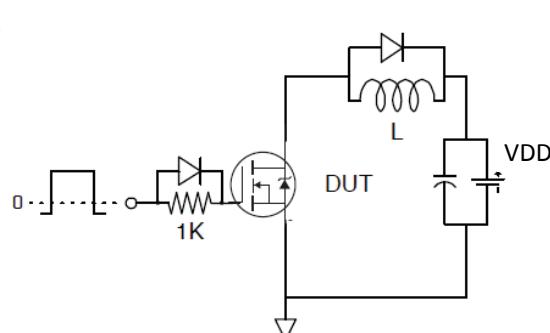


Fig 25a. Gate Charge Test Circuit

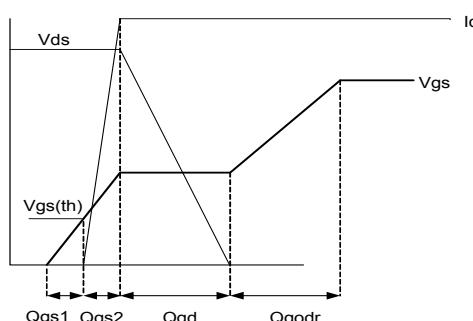
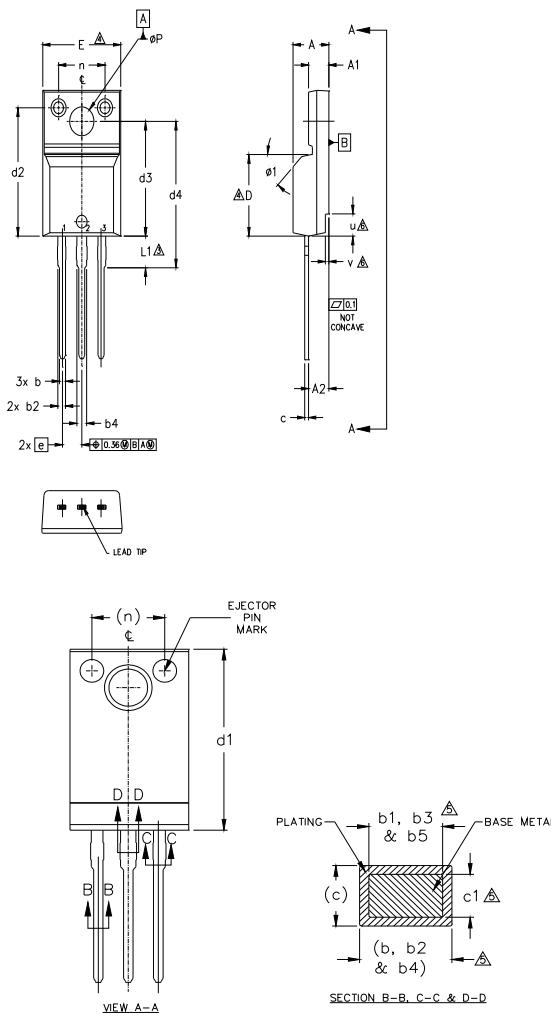


Fig 25b. Gate Charge Waveform

TO-220 Full-Pak Package Outline (Dimensions are shown in millimeters (inches))



NOTES:

- 1.0 DIMENSIONING AND TOLERANCING AS PER ASME Y14.5 M- 1994.
- 2.0 DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3.0 LEAD DIMENSION AND FINISH UNCONTROLLED IN L1.
- 4.0 DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTER MOST EXTREMES OF THE PLASTIC BODY.
- 5.0 DIMENSION b1, b3, b5 & c1 APPLY TO BASE METAL ONLY.
- 6.0 STEP OPTIONAL ON PLASTIC BODY DEFINED BY DIMENSIONS u & v.
- 7.0 CONTROLLING DIMENSION : INCHES.

S Y M B O L	DIMENSIONS				N O T E S	
	MILLIMETERS		INCHES			
	MIN.	MAX.	MIN.	MAX.		
A	4.57	4.83	.180	.190		
A1	2.57	2.83	.101	.111		
A2	2.41	2.92	.095	.115		
b	0.62	.094	.024	.037		
b1	0.62	0.89	.024	.035	5	
b2	0.76	1.27	.030	.050	5	
b3	0.76	1.22	.030	.048	5	
b4	1.02	1.52	.040	.060	5	
b5	1.02	1.47	.040	.058	5	
c	0.33	0.63	.013	.025	5	
c1	0.33	0.58	.013	.023	5	
D	8.65	9.80	.341	.386	4	
d1	15.80	16.12	.622	.635		
d2	13.97	14.22	.550	.560		
d3	12.30	12.92	.484	.509		
d4	8.64	9.91	.340	.390		
E	9.63	10.63	.379	.419		
e	2.54 BSC		.100 BSC			
L	13.20	13.72	.520	.540		
L1	3.10	2.31	.122	.138		
n	6.05	6.15	.238	.242		
øP	3.05	3.45	.120	.136	6	
u	2.40	2.50	.094	.098	6	
v	0.40	0.50	.016	.020	6	
ø1	—	45°	—	45°	6	

LEAD ASSIGNMENTSHEXFET

- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE

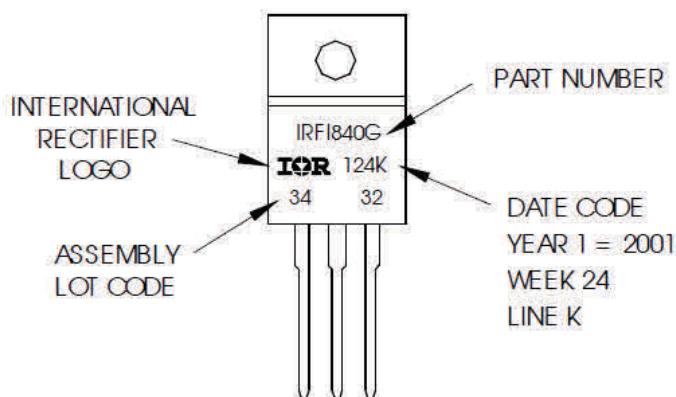
IGBTs, CoPACK

- 1.- GATE
- 2.- COLLECTOR
- 3.- Emitter

TO-220 Full-Pak Part Marking Information

EXAMPLE: THIS IS AN IRFI840G
WITH ASSEMBLY
LOT CODE 3432
ASSEMBLED ON WV 24, 2001
IN THE ASSEMBLY LINE "K"

Note: "P" in assembly line position
indicates "Lead-Free"



TO-220AB Full-Pak packages are not recommended for Surface Mount Application.

Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

Qualification Information[†]

Qualification Level	Industrial	
Moisture Sensitivity Level	TO-220 Full-Pak	N/A
RoHS Compliant	Yes	

[†] Qualification standards can be found at International Rectifier's web site: <http://www.irf.com/product-info/reliability/>

^{††} Applicable version of JEDEC standard at the time of product release.

International
IR Rectifier

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To contact International Rectifier, please visit <http://www.irf.com/whoto-call/>

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